

# **Phy 473**

## **Project**

**Due: 20/11/2019**

**Grade : 20 Marks**

In this project, you are asked to make a presentation on a selected characterization technique. Please pick one of the following techniques and let me know about your choice

- 1- Scanning Electron Microscopy (SEM)
- 2- X-RAY Diffraction

**The expected outline of the talk should be as follows:**

- 1- Brief Introduction about the technique
- 2- How it works?
- 3- Criteria for selection of the characterization technique (when we choose this techniques? With what materials?)
- 4- Advantages
- 5- Limitations
- 6- Applications